

P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY			
V _{DS} (V)	R _{DS(on)} (Ω) MAX.	I _D (A) ^{a, e}	Q _g (Typ.)
-20	0.076 at V _{GS} = -4.5 V	-2.9	7.5 nC
	0.100 at V _{GS} = -2.5 V	-2.5	
	0.145 at V _{GS} = -1.8 V	-2.1	
	0.320 at V _{GS} = -1.5 V	-0.5	

FEATURES

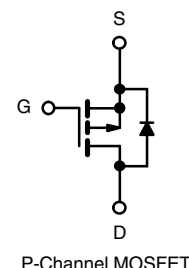
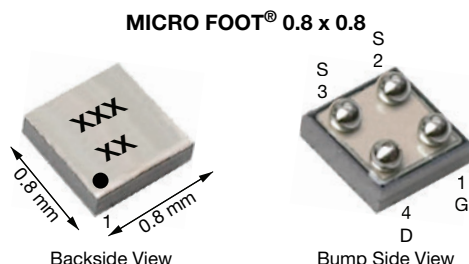
- TrenchFET® power MOSFET
- Small 0.8 mm x 0.8 mm outline area
- Low 0.4 mm max. profile
- Material categorization:
for definitions of compliance please see
www.vishay.com/doc?99912



RoHS
COMPLIANT
HALOGEN
FREE

APPLICATIONS

- Load switches and chargers switches
- Battery management
- DC/DC converters
- For smart phones and tablet PCs



Marking Code: xx = AF

xxx = Date/Lot traceability code

Ordering Information:

Si8817DB-T2-E1 (lead (Pb)-free and halogen-free)

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V _{DS}	-20	V
Gate-Source Voltage		V _{GS}	± 8	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	-2.9 ^a	A
	T _A = 70 °C		-2.3 ^a	
	T _A = 25 °C		-2.1 ^b	
	T _A = 70 °C		-1.7 ^b	
Pulsed Drain Current (t = 300 μs)		I _{DM}	-15	A
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	-0.7 ^a	
	T _A = 25 °C		-0.4 ^b	W
Maximum Power Dissipation	T _A = 25 °C	P _D	0.9 ^a	
	T _A = 70 °C		0.6 ^a	
	T _A = 25 °C		0.5 ^b	
	T _A = 70 °C		0.3 ^b	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to 150	°C
Package Reflow Conditions ^c	VPR		260	
	IR/Convection		260	

Notes

- Surface mounted on 1" x 1" FR4 board with full copper, t = 5 s.
- Surface mounted on 1" x 1" FR4 board with minimum copper, t = 5 s.
- Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering.
- In this document, any reference to case represents the body of the MICRO FOOT device and foot is the bump.
- Based on T_A = 25 °C.

**THERMAL RESISTANCE RATINGS**

PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT
Maximum Junction-to-Ambient ^{a, b}	t = 5 s	R _{thJA}	105	135	°C/W
Maximum Junction-to-Ambient ^{c, d}	t = 5 s		200	260	

Notes

- a. Surface mounted on 1" x 1" FR4 board with full copper.
b. Maximum under steady state conditions is 185 °C/W.
c. Surface mounted on 1" x 1" FR4 board with minimum copper.
d. Maximum under steady state conditions is 330 °C/W.

SPECIFICATIONS (T_J = 25 °C, unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = -250 μA	-20	-	-	V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = -250 μA	-	-12	-	mV/°C
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} /T _J		-	2.5	-	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = -250 μA	-0.4	-	-1	V
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 8 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -20 V, V _{GS} = 0 V	-	-	-1	μA
		V _{DS} = -20 V, V _{GS} = 0 V, T _J = 70 °C	-	-	-10	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≤ -5 V, V _{GS} = -4.5 V	-5	-	-	A
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = -4.5 V, I _D = -1 A	-	0.061	0.076	Ω
		V _{GS} = -2.5 V, I _D = -1 A	-	0.080	0.100	
		V _{GS} = -1.8 V, I _D = -0.5 A	-	0.110	0.145	
		V _{GS} = -1.5 V, I _D = -0.5 A	-	0.165	0.320	
Forward Transconductance ^a	g _{fs}	V _{DS} = -10 V, I _D = -1 A	-	5	-	S
Dynamic ^b						
Input Capacitance	C _{iss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	-	615	-	pF
Output Capacitance	C _{oss}		-	90	-	
Reverse Transfer Capacitance	C _{rss}		-	75	-	
Total Gate Charge	Q _g	V _{DS} = -10 V, V _{GS} = -8 V, I _D = -1 A	-	12.5	19	nC
Gate-Source Charge	Q _{gs}	V _{DS} = -10 V, V _{GS} = -4.5 V, I _D = -1 A	-	7.5	12	
Gate-Drain Charge	Q _{gd}		-	1	-	
Gate Resistance	R _g		-	1.9	-	
Gate Resistance	R _g	V _{GS} = -0.1 V, f = 1 MHz	-	14	-	Ω
Turn-On Delay Time	t _{d(on)}	V _{DD} = -10 V, R _L = 10 Ω I _D ≅ -1 A, V _{GEN} = -4.5 V, R _g = 1 Ω	-	20	40	ns
Rise Time	t _r		-	20	40	
Turn-Off Delay Time	t _{d(off)}		-	52	100	
Fall Time	t _f		-	22	45	
Turn-On Delay Time	t _{d(on)}	V _{DD} = -10 V, R _L = 10 Ω I _D ≅ -1 A, V _{GEN} = -8 V, R _g = 1 Ω	-	6	15	
Rise Time	t _r		-	10	20	
Turn-Off Delay Time	t _{d(off)}		-	60	120	
Fall Time	t _f		-	23	45	



SPECIFICATIONS ($T_J = 25\text{ }^{\circ}\text{C}$, unless otherwise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	$T_A = 25\text{ }^{\circ}\text{C}$	-	-	-0.7	A
Pulse Diode Forward Current	I_{SM}		-	-	-15	
Body Diode Voltage	V_{SD}	$I_S = -1\text{ A}$, $V_{GS} = 0\text{ V}$	-	-0.75	-1.2	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = -1\text{ A}$, $dI/dt = 100\text{ A}/\mu\text{s}$, $T_J = 25\text{ }^{\circ}\text{C}$	-	30	60	ns
Body Diode Reverse Recovery Charge	Q_{rr}		-	14	30	nC
Reverse Recovery Fall Time	t_a		-	13	-	ns
Reverse Recovery Rise Time	t_b		-	17	-	

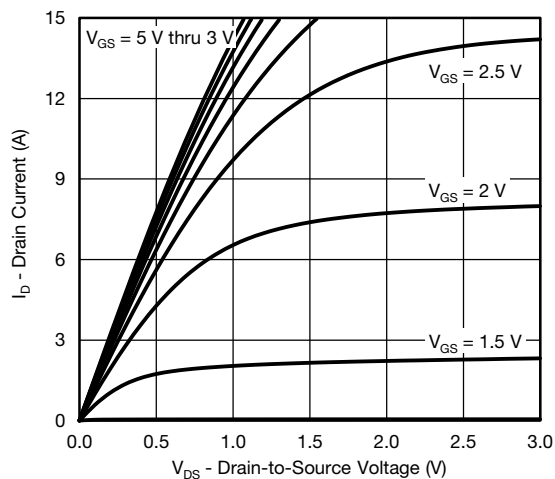
Notes

- Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$
- Guaranteed by design, not subject to production testing.

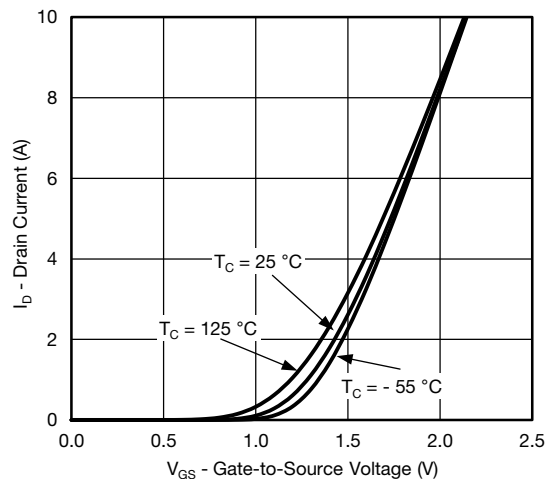
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



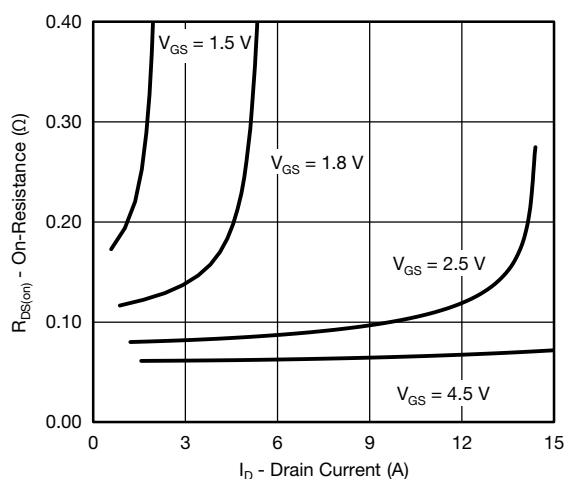
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



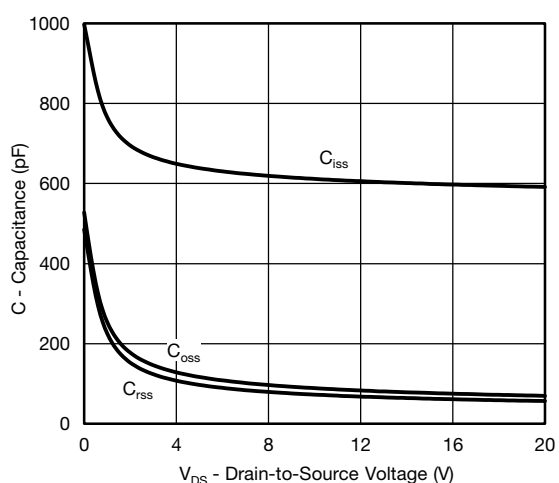
Output Characteristics



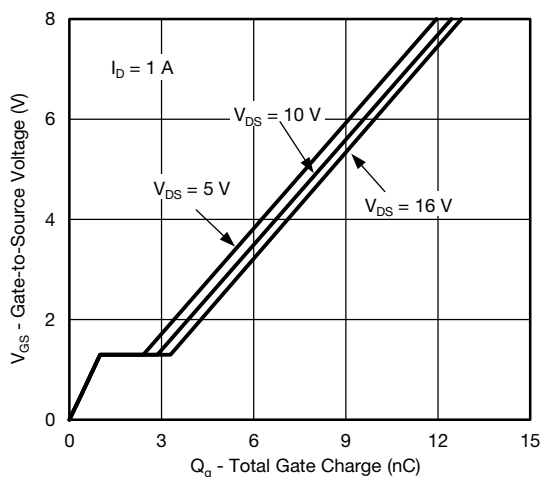
Transfer Characteristics



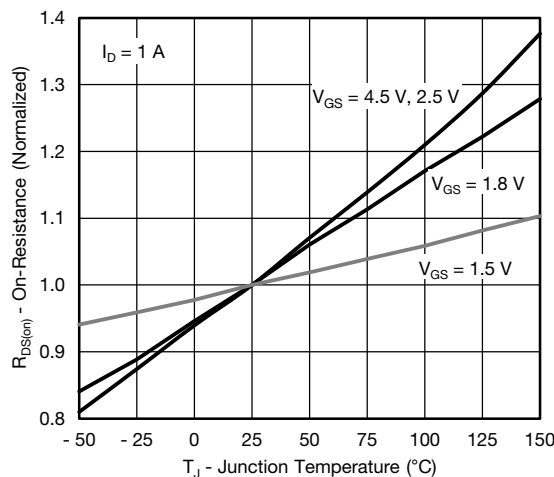
On-Resistance vs. Drain Current and Gate Voltage



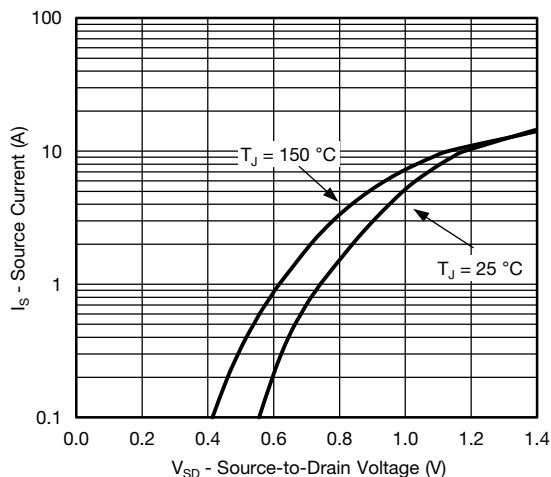
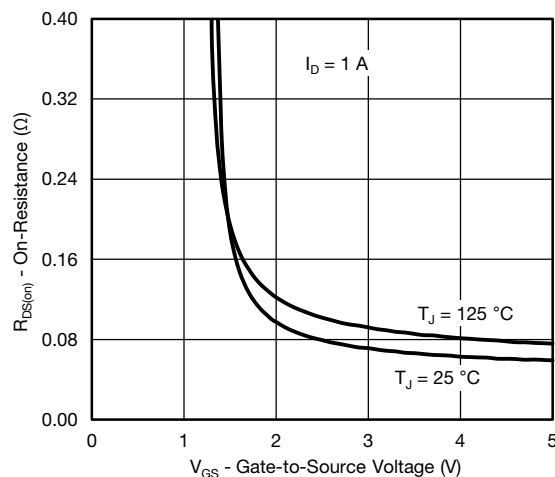
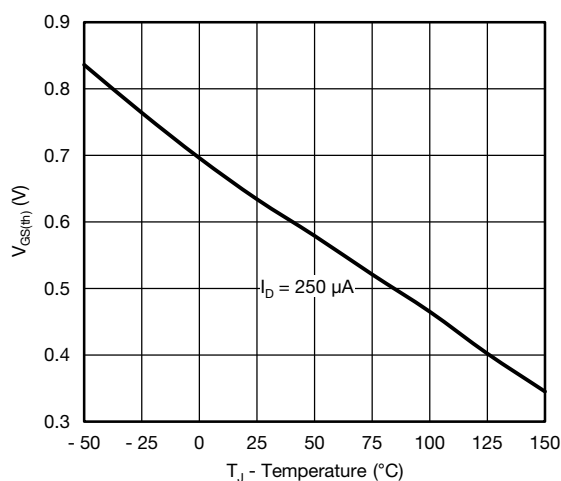
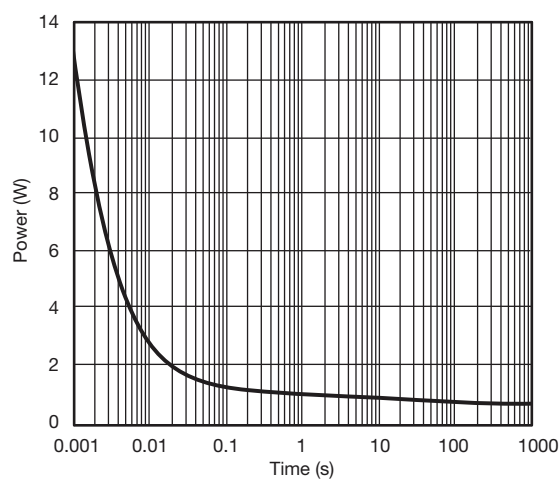
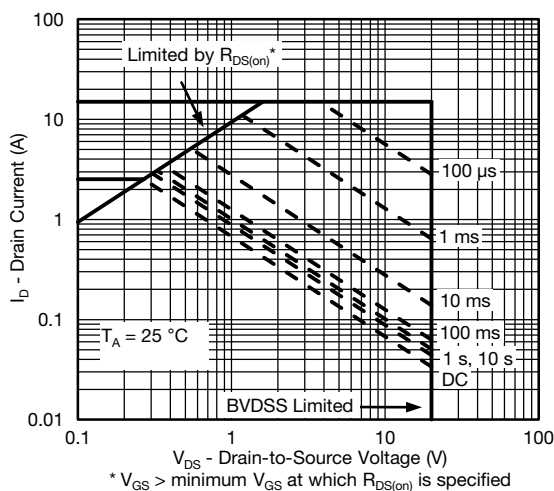
Capacitance

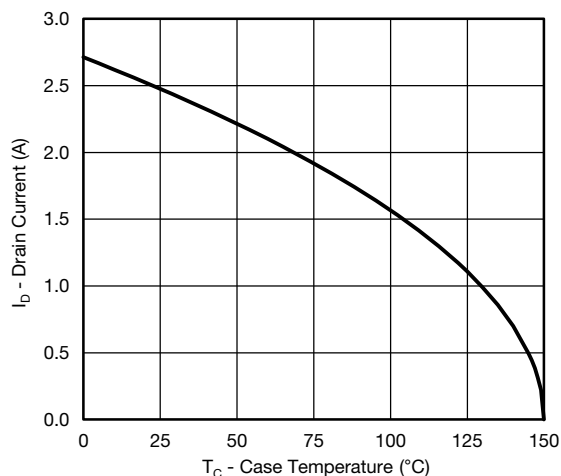


Gate Charge

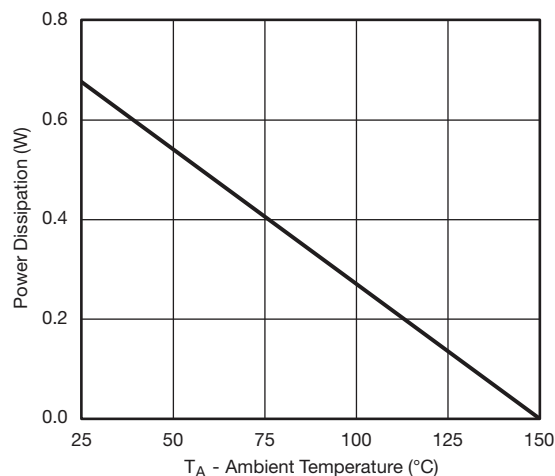


On-Resistance vs. Junction Temperature

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Source-Drain Diode Forward Voltage

On-Resistance vs. Gate-to-Source Voltage

Threshold Voltage

Single Pulse Power, Junction-to-Ambient

Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Current Derating*
Note

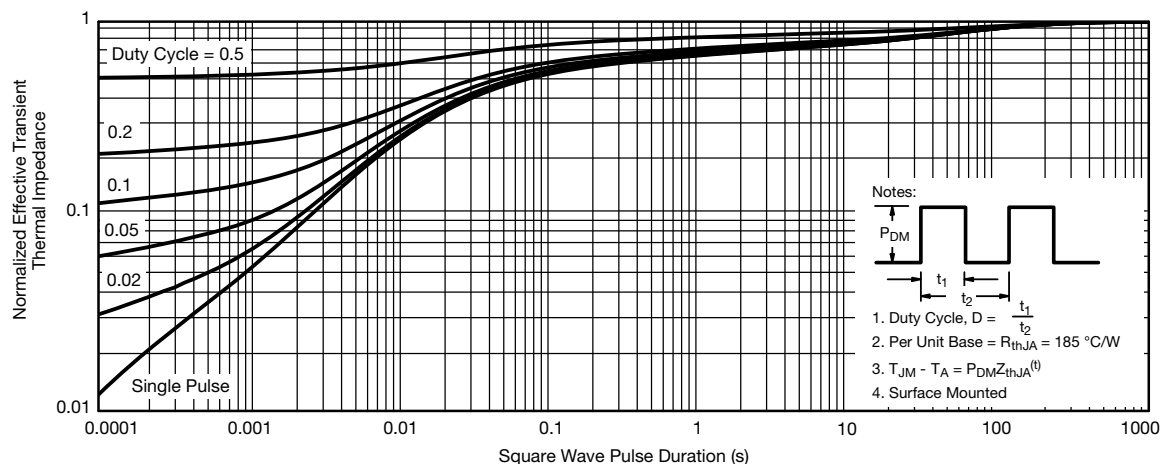
When mounted on 1" x 1" FR4 with full copper.


Power Derating

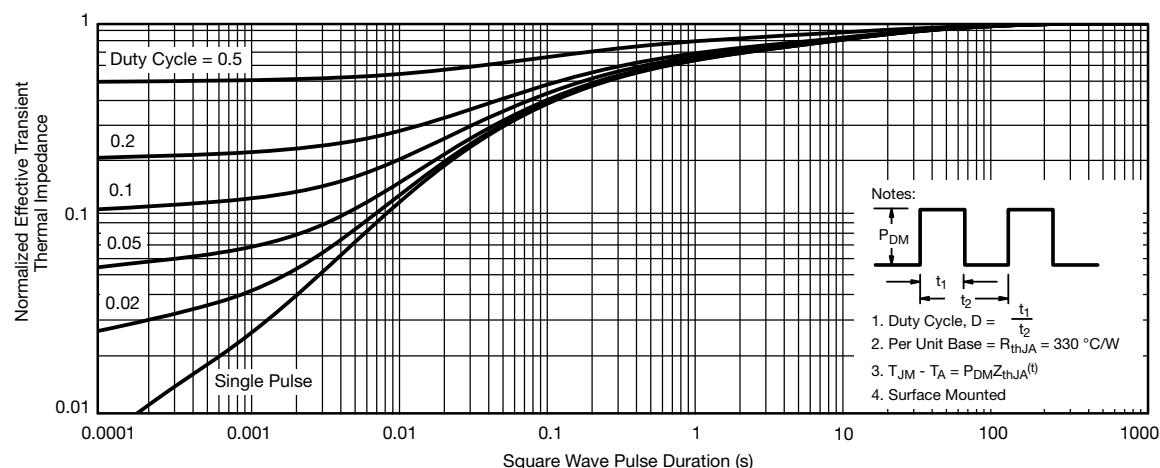
* The power dissipation P_D is based on $T_{J(max)} = 150\text{ °C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient (On 1" x 1" FR4 Board with Maximum Copper)



Normalized Thermal Transient Impedance, Junction-to-Ambient (On 1" x 1" FR4 Board with Minimum Copper)

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